

Issue Classification 	Application No.	Applicant(s)	
	10/627,218	YEO ET AL.	
	Examiner	Art Unit	
	Nguyen T Ha	2831	

ORIGINAL		CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
361	302	361	303	305	301.1	301.5	321.1	
INTERNATIONAL CLASSIFICATION		257	402	403				
H	0	1	G	4/35				
			/					
			/					
			/					
			/					
Nguyen T. Ha 2/2/2005 (Assistant Examiner) (Date)		<i>Dean A. Reichard</i> DEAN A. REICHARD SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) 2/17/05 (Date)					Total Claims Allowed: 81	
Dawn Ewart 2/17/05 (Legal Instruments Examiner) (Date)							O.G. Print Claim(s) 1	O.G. Print Fig. 2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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4	1	34	35	64	65	94	124
5	1	35	36	65	66	95	125
6	1	36	37	66	67	96	126
7	1	37	38	67	68	97	127
8	1	38	39	68	69	98	128
9	1	39	40	69	70	99	129
10	1	40	41	70	71	100	130
11	1	41	42	71	72	101	131
12	1	42	43	72	73	102	132
13	1	43	44	73	74	103	133
14	1	44	45	74	75	104	134
15	1	45	46	75	76	105	135
16	1	46	47	76	77	106	136
17	1	47	48	77	78	107	137
18	1	48	49	78	79	108	138
19	1	49	50	79	80	109	139
20	1	50	51	80	81	110	140
21	1	51	52	81	82	111	141
22	1	52	53	82	83	112	142
23	1	53	54	83	84	113	143
24	1	54	55	84	85	114	144
25	1	55	56	85	86	115	145
26	1	56	57	86	87	116	146
27	1	57	58	87	88	117	147
28	1	58	59	88	89	118	148
29	1	59	60	89	90	119	149
30	1	60				120	150